

Features

- 0402 0.55mm SMD LED
- High Brightness
- AllnGaP / InGaN Technology
- Small package
- High reliability
- Clear Lens

Applications

- Consumer Electronics
- Wearables
- Automobile After Market
- Industrial Equipment

Description

The IN-S42DS series is a popular low profile 0402 package with versatile design capabilities. It is a PCB type molding style LED which can be used in various applications.

Recommended Solder Pattern

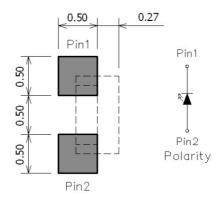
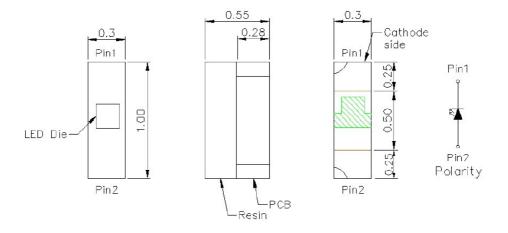


Figure 1. IN-S42DS Solder Pattern

Package Dimensions in mm



Notes.

- 1. All dimensions are in millimeters.
- 2. Tolerance is ± 0.10 mm unless otherwise noted

Figure 2. IN-S42DS Package Dimensions



Absolute Maximum Rating at 25°C (Note 1)

Product	Emission Color	P _d (mW)	I _F (mA)	I _{FP} * (mA)	V _R (V)	T _{OP} (°C)	T _{ST} (°C)
IN-S42DS5SR	Super Red	48	20	100	5	-40°C~+85°C	-40°C~+100°C
IN-S42DS5R	Red	48	20	100	5	-40°C~+85°C	-40°C~+100°C
IN-S42DS5YG	Yellow Green	48	20	100	5	-40°C~+85°C	-40°C~+100°C
IN-S42DS5Y	Yellow	48	20	100	5	-40°C~+85°C	-40°C~+100°C
IN-S42DS5A	Amber	48	20	100	5	-40°C~+85°C	-40°C~+100°C
IN-S42DS5B	Blue	15.75	5	80	5	-40°C~+85°C	-40°C~+100°C
IN-S42DS5G	Green	78	20	80	5	-40°C~+85°C	-40°C~+100°C
IN-S42DS5UW	White	36	10	80	5	-40°C~+85°C	-40°C~+100°C

Notes

1. Condition for IFP is pulse of 1/10 duty and 0.1msec width

ESD Precaution

ATTENTION: Electrostatic Discharge (ESD) protection



The symbol above denotes that ESD precaution is needed. ESD protection for GaP and AlGaAs based chips is necessary even though they are relatively safe in the presence of low static-electric discharge. Parts built with AllnGaP, GaN, or/and InGaN based chips are STATIC SENSITIVE devices. ESD precaution must be taken during design and assembly. If manual work or processing is needed, please ensure the device is adequately protected from ESD during the process.

Please be advised that normal static precautions should be taken in the handling and assembly of this device to prevent damage or degradation which may be induced by electrostatic discharge (ESD).



Electrical Characteristics $T_A = 25\%$ (Note 1)

	Emission		V _F (V)		λ(nm)			Viewing Angle	I* _V (mcd)
Product	Color	I _F (mA)	typ.	max	λ_{D}	$\lambda_{ extsf{P}}$	Δλ	2 <i>0</i> 1/2	typ.
IN-S42DS5SR	Super Red	5	2.0	2.4	631	639	20	145	18.0
IN-S42DS5R	Red	5	2.0	2.4	624	632	20	145	28.5
IN-S42DS5YG	Yellow Green	5	2.1	2.4	571	573	15	145	11.25
IN-S42DS5Y	Yellow	5	2.0	2.4	589	591	20	145	18.0
IN-S42DS5A	Amber	5	2.0	2.4	605	611	17	145	28.5
IN-S42DS5B	Blue	5	2.8	3.15	472	470	40	145	28.5
IN-S42DS5G	Green	5	2.7	3.0	529	522	40	145	71.5
IN-S42DS5UW	White	5	2.9	3.25	X=0.290 Y=0.285	-	-	X=150 Y=140	200.0

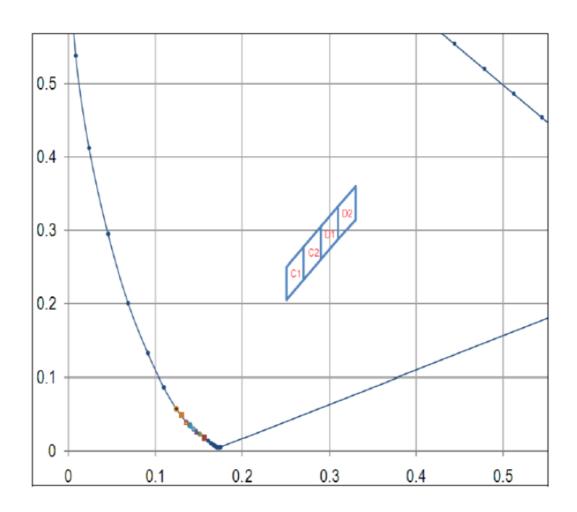
Notes

^{1.} Performance guaranteed only under conditions listed in above tables.



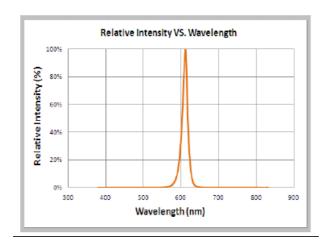
Chromaticity Bin (for White only)

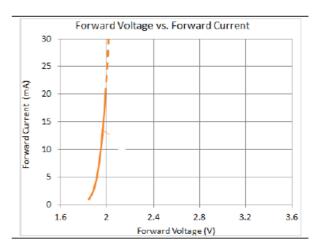
Bin Code	CIE-X	CIE-Y	Bin Code	CIE-X	CIE-Y
	0.2500	0.2050		0.2700	0.2325
C1	0.2500	0.2500	C2	0.2700	0.2775
Ci	0.2700	0.2775	C2	0.2900	0.3050
	0.2700	0.2325		0.2900	0.2600
Bin Code	CIE-X	CIE-Y	Bin Code	CIE-X	CIE-Y
	0.2900	0.2600		0.3100	0.2875
D1	0.2900	0.3025	D2	0.3100	0.3325
DI	0.3100	0.3325	DZ	0.3300	0.3600
	0.3100	0.2875		0.3300	0.3150

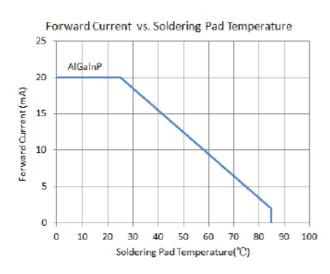


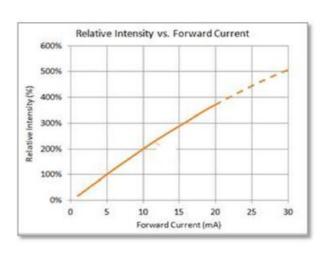


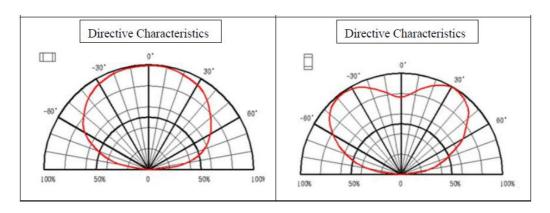
Typical Characteristic Curves -A





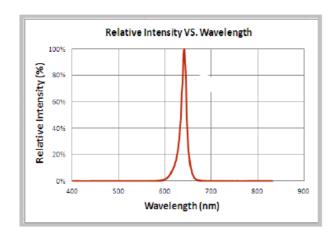


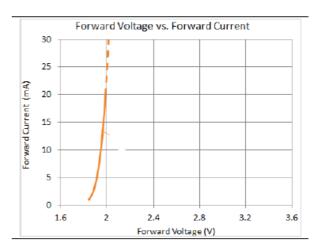


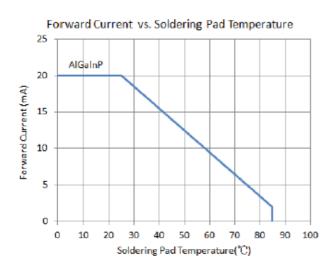


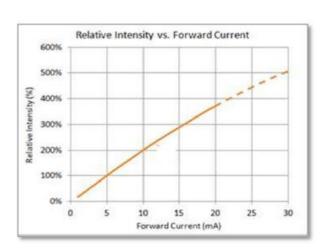


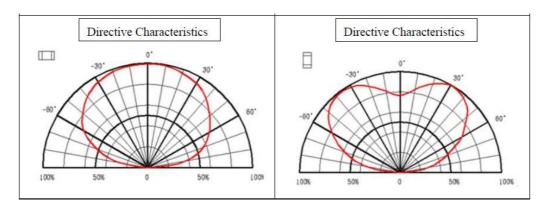
Typical Characteristic Curves -SR





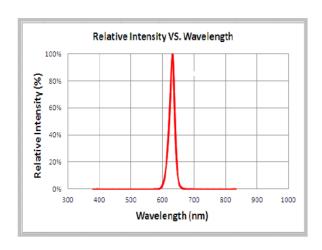


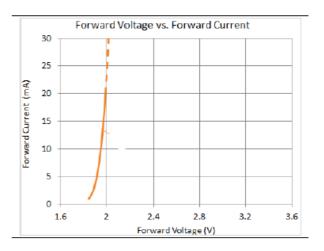


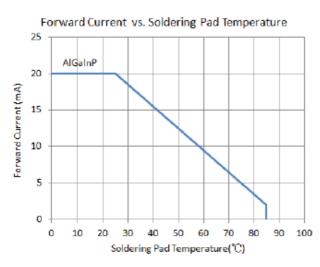


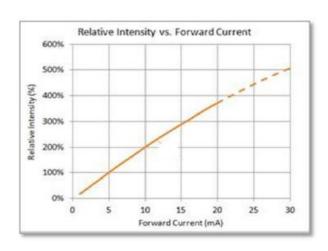


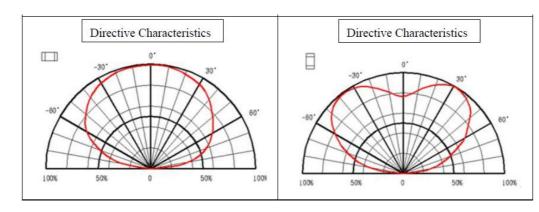
Typical Characteristic Curves -R





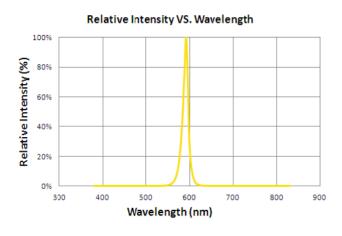


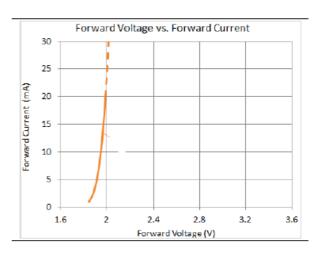


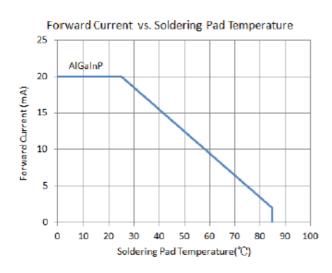


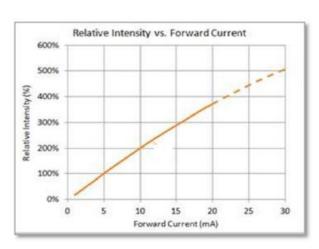


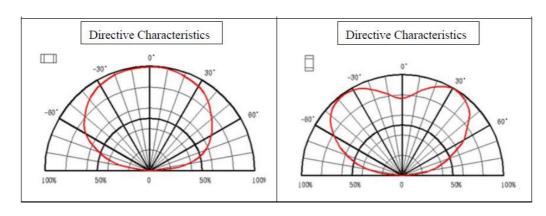
Typical Characteristic Curves -Y





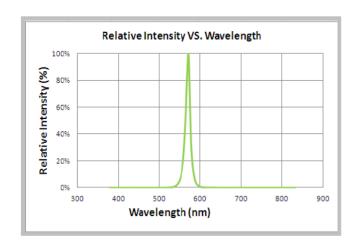


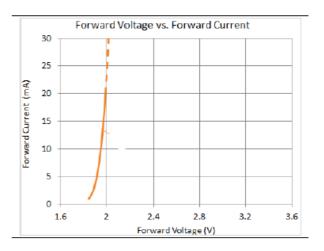


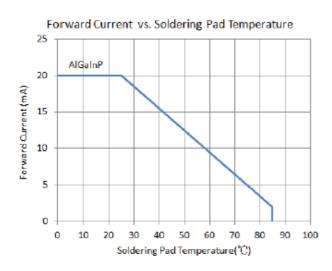


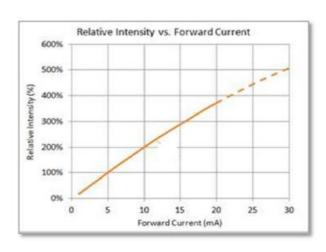


Typical Characteristic Curves -YG

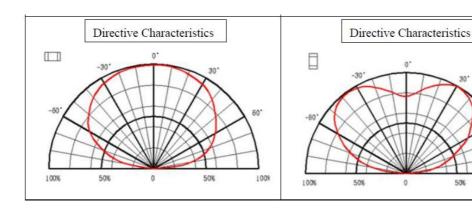








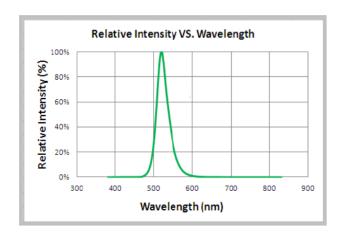
Typical Characteristic Curves – Radiation Pattern

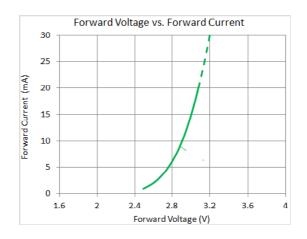


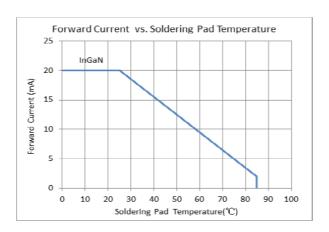
100%

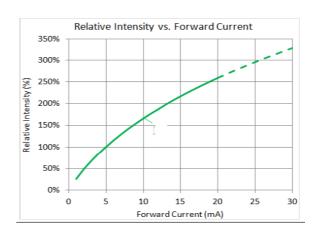


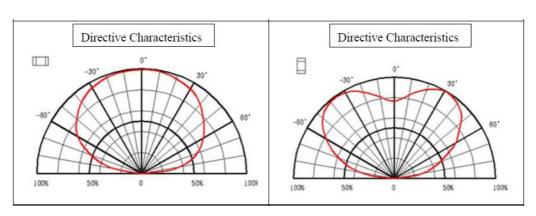
Typical Characteristic Curves -G





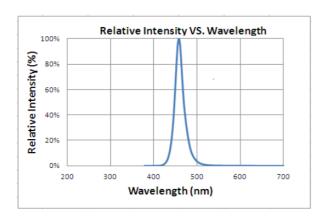


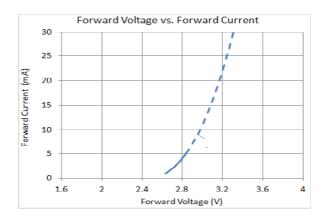


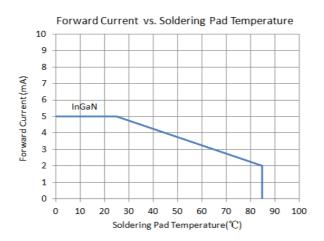


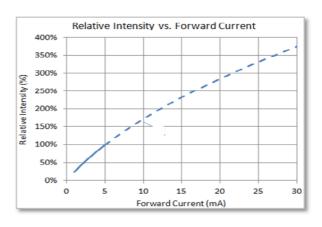


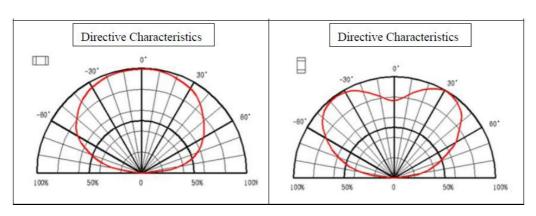
Typical Characteristic Curves -B





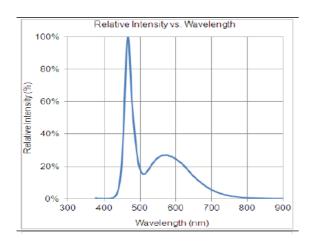


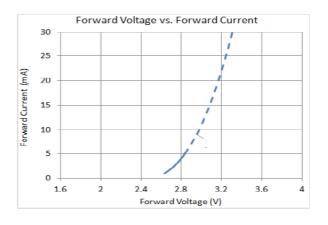


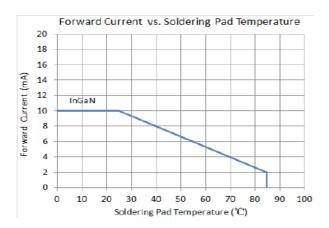


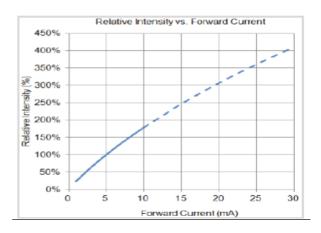


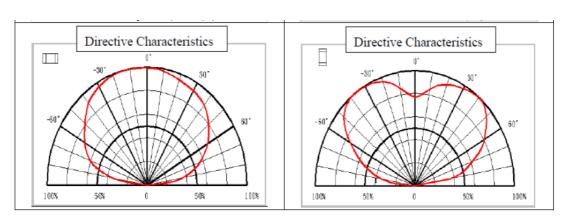
Typical Characteristic Curves –W











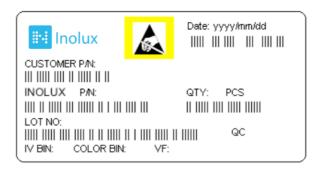


Ordering Information

Product	Emission Color	Technology	Test Current I _F (mA)	Luminous Intensity I _V (mcd) (Typ.)	Forward Voltage V _F (V) (Typ.)	Orderable Part Number
IN-S42DS5SR	Super Red	AllnGaP	5	18.0	2.0	IN-S42DS5SR
IN-S42DS5R	Red	AllnGaP	5	28.5	2.0	IN-S42DS5R
IN-S42DS5YG	Yellow Green	AllnGaP	5	11.5	2.0	IN-S42DS5YG
IN-S42DS5Y	Yellow	AllnGaP	5	23	2.0	IN-S42DS5Y
IN-S42DS5A	Amber	AllnGaP	5	28.5	2.0	IN-S42DS5A
IN-S42DS5B	Blue	InGaN	5	28.5	2.8	IN-S42DS5B
IN-S42DS5G	Green	InGaN	5	71.5	2.8	IN-S42DS5G
IN-S42DS5UW	White	InGaN	5	200	2.9	IN-S42DS5UW



Label Specifications



Inolux P/N:

I	N	-	S	4	2	D	S	5	-		-	ı	-	-	-
			Material	Pacl	kage	Variation	Orientation	Current	Lens	Color			ıstor tam _l		
	blux MD		S = PCB Type	42	2D = 1.(0.55r) x 0.5 x mm	S = Side Mount	5=5mA	(Blank) = Clear U = Diffused	SR=631m R=624nm A=605nm Y=590nm YG=570nm G=520nm B=470nm W=White			-		

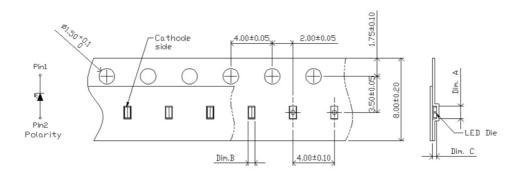
Lot No.:

Z	2	0	1	7	01	24	001
Internal		Voor (2017	2010 \	Month	Data	Coriol	
Tracker		Year (2017	, 2018,)	Month	Date	Serial	



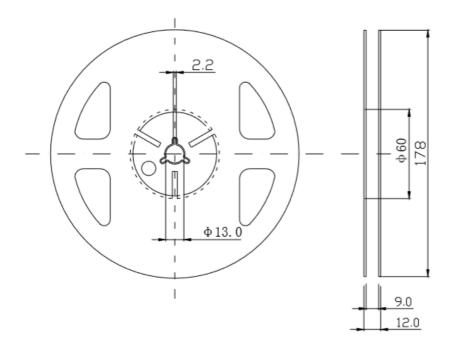
Packaging Information: 4000pcs Per Reel

Tape Dimension



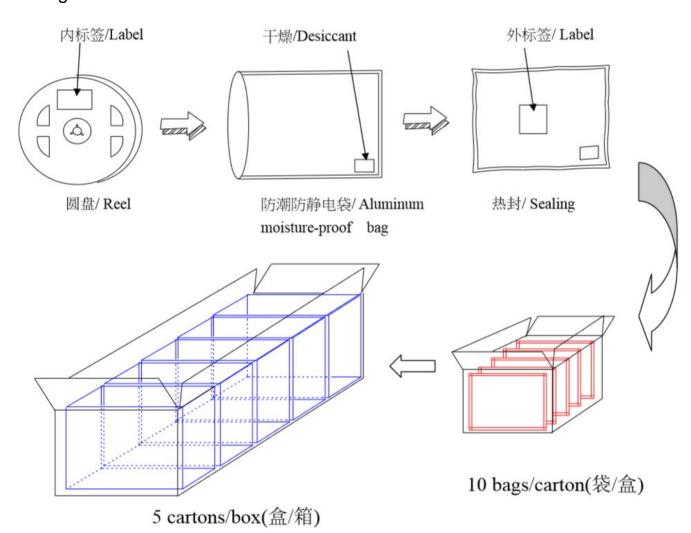
Dim. A	Dim. B	Dim. C	Q'ty/Reel
1.2 ±0.05	0.65 ± 0.05	0.42 ± 0.05	4K

Reel Dimension





Packing Dimension



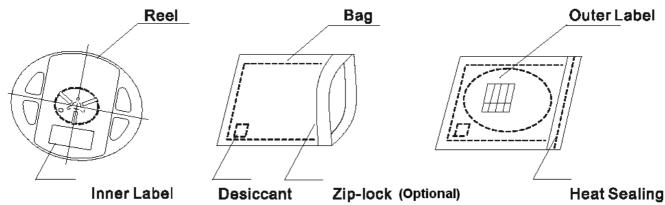


Dry Pack

All SMD optical devices are **MOISTURE SENSITIVE**. Avoid exposure to moisture at all times during transportation or storage. Every reel is packaged in a moisture protected anti-static bag. Each bag is properly sealed prior to shipment.

Upon request, a humidity indicator will be included in the moisture protected anti-static bag prior to shipment.

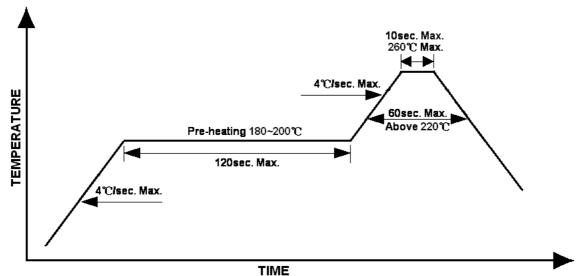
The packaging sequence is as follows:



Reflow Soldering

- Recommended tin glue specifications: melting temperature in the range of 178~192 °C
- The recommended reflow soldering profile is as follows (temperatures indicated are as measured on the surface of the LED resin):

Lead-free Solder Profile





Precautions

- Avoid exposure to moisture at all times during transportation or storage.
- Anti-Static precaution must be taken when handling GaN, InGaN, and AllnGaP products.
- It is suggested to connect the unit with a current limiting resistor of the proper size. Avoid applying a reverse voltage.
- Avoid operation beyond the limits as specified by the absolute maximum ratings.
- · Avoid direct contact with the surface through which the LED emits light.
- If possible, assemble the unit in a clean room or dust-free environment.

Reworking

- Rework should be completed within 5 seconds under 260 °C.
- The iron tip must not come in contact with the copper foil.
- Twin-head type is preferred.

Cleaning

Following are cleaning procedures after soldering:

- An alcohol-based solvent such as isopropyl alcohol (IPA) is recommended.
- Temperature x Time should be 50°C x 30sec. or <30°C x 3min
- Ultra sonic cleaning: < 15W/ bath; bath volume ≤ 1liter
- Curing: 100 °C max, <3min

Cautions of Pick and Place

- Avoid stress on the resin at elevated temperature.
- Avoid rubbing or scraping the resin by any object.
- Electro-static may cause damage to the component. Please ensure that the equipment is properly grounded. Use of an ionizer fan is recommended.



IN-S42DS series Side View SMD LED 0402 PCB Type

Reliability

Tailures Reference For all reliability J-STD-020 1.) Baking at 85°C for 24hrs 2.) Moisture storage at 85°C / 60% R.H. for 168hrs 2.) Moisture storage at 85°C / 60% R.H. for 168hrs 2.) Moisture storage at 85°C / 60% R.H. for 168hrs 2.) Moisture storage at 85°C / 24hrs 3.) Moisture storage at 85°	liability			
Precondition	Item			Conditions
Precondition				4) 5 1: 40500 (0.4)
To JEDEC Level 2 168hrs 10/1/22/0 JESD22-B102-B Accelerated aging 155°C/24hrs And CNS-5068 Tinning speed: 2.5+0.5cm/s Tinning: A: 215°C/3+1s or B: 260°C/10+1s Soldering bath temperature Soldering bat			J-S1D-020	
Solderability	Precondition			
And CNS-5068 Tinning speed: 2.5+0.5cm/s Tinning: A: 215°C/ 3+1s or B: 260°C/ 10+1s				
Tinning: Á: 215°C/ 3+1s or B: 260°C/ 10+1s		1Q/ 1/ 22/ 0	JESD22-B102-B	Accelerated aging 155°C/ 24hrs
CNS-5067 Dipping soldering terminal only Soldering bath temperature A: 260+/-5°C; 10+/-1s B: 350+/-10°C; 3+/-0.5s	Solderability		And CNS-5068	Tinning speed: 2.5+0.5cm/s
Soldering bath temperature Soldering bath temperature A: 260+/-5°C; 10+/-18 B: 350+/-10°C; 3+/-0.5s 1Q/ 1/ 40/ 0				Tinning: A: 215°C/ 3+1s or B: 260°C/ 10+1s
A: 260+/-5°C; 10+/-1s B: 350+/-10°C; 3+/-0.5s 1Q/ 1/ 40/ 0 CNS-11829 1.) Precondition: 85°C baking for 24hrs 85°C/ 60%R.H. for 168hrs 2.) Tamb25°C; IF=20mA; duration 1000hrs High humidity, high temperature bias High temperature bias 1Q/ 1/ 40/ 0 Fulse life test 1Q/ 1/ 40/ 0 Temperature cycle 1Q/ 1/ 76/ 0 Temperature cycle IN Specs. A: 260+/-5°C; 10+/-1s B: 350+/-10°C; 3+/-0.5s 1.) Precondition: 85°C baking for 24hrs 85°C/ 60%R.H. for 168hrs 2.) Tamb25°C; IF=20mA; duration 1000hrs Tamb: 85°C Humidity: 85% R.H., IF=5mA Duration: 1000hrs Tamb: 55°C IF=20mA, IP=100mA, Duty cycle=0.125 (tp=125 \(mu\) s,T=1sec) Duration 500hrs) A cycle: -40 degree C 15min; +85 degree C 15min Thermal steady within 5 min 300 cycles 2 chamber/ Air-to-air type High humidity storage test High temperature 1Q/ 1/ 40/ 0 CNS-6117 CNS-554 100+10°C for 500hrs -40+5°C for 500hrs			CNS-5067	Dipping soldering terminal only
A: 260+/-5°C; 10+/-1s B: 350+/-10°C; 3+/-0.5s IQ/ 1/ 40/ 0 CNS-11829 1.) Precondition: 85°C baking for 24hrs 85°C / 60%R.H. for 168hrs 2.) Tamb25°C; IF=20mA; duration 1000hrs High humidity, high temperature bias IQ/ 1/ 45/ 0 High temperature bias IQ/ 1/ 20 IN specs. IF=20mA, IF=5mA Duration: 1000hrs IQ/ 1/ 40/ 0 IN specs. IF=20mA, IF=100mA, Duty IV IV IV IV IV IV IV IV	Resistance to			Soldering bath temperature
B: 350+/-10°C; 3+/-0.5s	soldering heat			A: 260+/-5°C; 10+/-1s
1Q/ 1/ 40/ 0 CNS-11829 1.) Precondition: 85°C baking for 24hrs 85°C/ 60%R.H. for 168hrs 2.) Tamb25°C; IF=20mA; duration 1000hrs				B: 350+/-10°C; 3+/-0.5s
Operating life test 85°C/ 60%R.H. for 168hrs High humidity, high temperature bias 1Q/ 1/ 45/ 0 High temperature bias IQ/ 1/ 20 High temperature bias IN specs. Tamb: 55°C Humidity: 85% R.H., IF=5mA Duration: 1000hrs High temperature bias IQ/ 1/ 20 High temperature bias IQ/ 1/ 40/ 0 Tamb: 55°C IF=20mA Duration: 1000hrs Tamb: 55°C IF=20mA, IP=100mA, Duty Cycle=0.125 (tp=125 μ s,T=1sec) Duration: 500hrs Temperature cycle IQ/ 1/ 76/ 0 JESD-A104-A IEC 68-2-14, Nb A cycle: -40 degree C 15min; +85 degree C 15min Thermal steady within 5 min 300 cycles 2 chamber/ Air-to-air type High humidity storage test IQ/ 1/ 40/ 0 High temperature storage test IQ/ 1/ 40/ 0 Low temperature IQ/ 1/ 40/ 0 CNS-6118 -40+5°C for 500hrs		1Q/ 1/ 40/ 0	CNS-11829	
2.) Tamb25°C; IF=20mA; duration 1000hrs	Operating life test			
High humidity, high temperature bias 1Q/ 1/ 45/ 0 JESD-A101-B Tamb: 85°C Humidity: 85% R.H., IF=5mA Duration: 1000hrs High temperature bias 1Q/ 1/ 20 IN specs. Tamb: 55°C IF=20mA Duration: 1000hrs Pulse life test 1Q/ 1/ 40/ 0 Tamb: 55°C IF=20mA, Ip=100mA, Duty cycle=0.125 (tp=125 μ s,T=1sec) Duration 500hrs) Pulse life test 1Q/ 1/ 76/ 0 JESD-A104-A IEC 68-2-14, Nb A cycle: -40 degree C 15min; +85 degree C 15min Thermal steady within 5 min. 300 cycles 2 chamber/ Air-to-air type High humidity storage test 1Q/ 1/ 40/ 0 CNS-6117 60+3°C 90+5/-10% R.H. for 500hrs High temperature storage test 1Q/ 1/ 40/ 0 CNS-554 100+10°C for 500hrs Low temperature 1Q/ 1/ 40/ 0 CNS-6118 -40+5°C for 500hrs	- p - v - m · · · · · · · ·			
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F=20mA Duration: 1000hrs		10/ 1/ 20	IN specs	
Duration: 1000hrs $1Q/ 1/ 40/ 0$ Pulse life test $1Q/ 1/ 40/ 0$ Pulse life test $1Q/ 1/ 76/ 0$ Temperature cycle $1Q/ 1/ 76/ 0$ Temperature cycle $1Q/ 1/ 40/ 0$ Temperature steady within 5 min 300 cycles $2 \text{ chamber/ Air-to-air type}$ $60+3^{\circ}\text{C}$ $90+5/-10\% \text{ R.H. for 500hrs}$ Thigh temperature storage test $1Q/ 1/ 40/ 0$ CNS-554 $100+10^{\circ}\text{C for 500hrs}$ $100+10^{\circ}\text{C for 500hrs}$		1 47 17 20	in Copooo.	
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storage test Low temperature 1Q/ 1/ 40/ 0 CNS-6118 -40+5°C for 500hrs				
Low temperature 1Q/ 1/ 40/ 0 CNS-6118 -40+5°C for 500hrs	High temperature	1Q/ 1/ 40/ 0	CNS-554	100+10°C for 500hrs
	storage test			
storage test	Low temperature	1Q/ 1/ 40/ 0	CNS-6118	-40+5°C for 500hrs
	storage test			



IN-S42DS series Side View SMD LED 0402 PCB Type

Revision History

Changes since last revision	Page	Version No.	Revision Date
Initial Release		1.0	05-14-2021

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